

## CD4032B, CD4038B Types

### CMOS Triple Serial Adders

#### High-Voltage Types (20-Volt Rating)

Positive Logic Adder — CD4032B

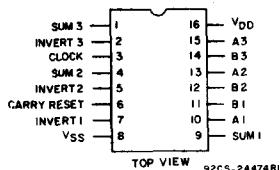
Negative Logic Adder — CD4038B

The RCA-CD4032B and CD4038B types consist of three serial adder circuits with common CLOCK and CARRY-RESET inputs. Each adder has provisions for two serial DATA INPUT signals and an INVERT command signal. When the command signal is a logical "1", the sum is complemented. Data words enter the adder with the least significant bit first; the sign bit trails. The output is the MOD 2 sum of the input bits plus the carry from the previous bit position. The carry is only added at the positive-going clock transition for the CD4032B or at the negative-going clock for the CD4038B, thus, for spike-free operation the input data transitions should occur as soon as possible after the triggering edge.

The CARRY is reset to a logical "0" at the end of each word by applying a logical "1" signal to a CARRY-RESET input one-bit position before the application of the first bit of the next word.

The CD4032B and CD4038B types are supplied in 16-lead hermetic dual-in-line ceramic packages (D and F suffixes), 16-lead dual-in-line plastic packages (E suffix), 16-lead ceramic flat packages (K suffix), and in chip form (H suffix).

**CD4032B, CD4038B  
TERMINAL DIAGRAM**



#### Features:

- Invert inputs on all adders for sum complementing applications
- Fully static operation . . . . dc to 10 MHz (typ.) @  $V_{DD} = 10$  V
- Single-phase clocking
- Standardized, symmetrical output characteristics
- 100% tested for quiescent current at 20 V
- 5-V, 10-V, and 15-V parametric ratings
- Maximum input current of 1  $\mu$ A at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (over full package-temperature range)

1 V at  $V_{DD} = 5$  V

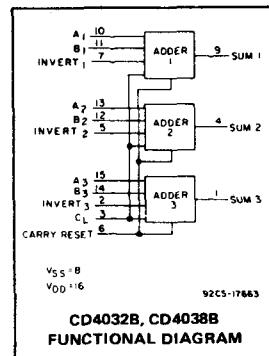
2 V at  $V_{DD} = 10$  V

2.5 V at  $V_{DD} = 15$  V

- Meets all requirements of JEDEC Tentative Standard No. 13A, "Standard Specifications for Description of 'B' Series CMOS Devices"

#### Applications:

- Serial arithmetic units
- Digital correlators
- Digital datalink computers
- Flight control computers
- Digital servo control systems



#### MAXIMUM RATINGS, Absolute-Maximum Values:

DC SUPPLY-VOLTAGE RANGE, ( $V_{DD}$ )  
(Voltages referenced to  $V_{SS}$  Terminal) ..... -0.5 to +20 V

INPUT VOLTAGE RANGE, ALL INPUTS ..... -0.5 to  $V_{DD}$  +0.5 V

DC INPUT CURRENT, ANY ONE INPUT ..... ±10 mA

POWER DISSIPATION PER PACKAGE ( $P_D$ ):  
For  $T_A = -40$  to +60°C (PACKAGE TYPE E) ..... 500 mW

For  $T_A = +60$  to +85°C (PACKAGE TYPE E) ..... Derate Linearly at 12 mW/°C to 200 mW

For  $T_A = -55$  to +100°C (PACKAGE TYPES D, F, K) ..... 500 mW

For  $T_A = +100$  to +125°C (PACKAGE TYPES D, F, K) ..... Derate Linearly at 12 mW/°C to 200 mW

DEVICE DISSIPATION PER OUTPUT TRANSISTOR  
For  $T_A$  = FULL PACKAGE-TEMPERATURE RANGE (All Package Types) ..... 100 mW

OPERATING-TEMPERATURE RANGE ( $T_A$ ):  
PACKAGE TYPES D, F, K, H ..... -55 to +125°C

PACKAGE TYPE E ..... -40 to +85°C

STORAGE TEMPERATURE RANGE ( $T_{STG}$ ) ..... -65 to +150°C

LEAD TEMPERATURE (DURING SOLDERING):  
At distance 1/16 ± 1/32 inch (1.59 ± 0.79 mm) from case for 10 s max. ..... +265°C

#### RECOMMENDED OPERATING CONDITIONS at $T_A = 25^\circ\text{C}$ , Unless Otherwise Specified

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges.

| CHARACTERISTIC   | $V_{DD}$ | Min. | Max. | UNITS         |
|--|----------|------|------|---------------|
| Supply Voltage Range (at $T_A$ = Full Package-Temperature Range) |          | 3    | 18   | V             |
| Clock Input Frequency, $f_{CL}$                                  | 5        | —    | 2.5  | MHz           |
|  | 10       | —    | 5    |               |
|  | 15       | —    | 7.5  |               |
| Clock Input Rise or Fall Time, $t_{rCL}, t_{fCL}$                | 5        | —    | 500  | $\mu\text{s}$ |
|  | 10       | —    | 500  |               |
|  | 15       | —    | 500  |               |
| Data Input Set-Up Time, Clock to A or B Inputs, $t_{SU}$         | 5        | 200  | —    | ns            |
|  | 10       | 80   | —    |               |
|  | 15       | 60   | —    |               |

## CD4032B, CD4038B Types

### STATIC ELECTRICAL CHARACTERISTICS

| CHARAC-<br>TERISTIC                                | CONDITIONS   |                 |                 | LIMITS AT INDICATED TEMPERATURES (°C)                  |           |         |         |       |               | U<br>N<br>I<br>T<br>S |         |
|--|--------------|-----------------|-----------------|--|-----------|---------|---------|-------|---------------|-----------------------|---------|
|  |              |                 |                 | Values at -55, +25, +125 Apply to D, F, K, H, Packages |           |         |         | +25   |               |                       |         |
|  | $V_O$<br>(V) | $V_{IN}$<br>(V) | $V_{DD}$<br>(V) | -55  | -40       | +85     | +125    | Min.  | Typ.          | Max.                  |         |
| Quiescent<br>Device<br>Current,<br>$I_{DD}$ Max.   | --           | 0.5             | 5               | 5  | 5         | 150     | 150     | --    | 0.04          | 5                     | $\mu A$ |
|  | --           | 0.10            | 10              | 10   | 10        | 300     | 300     | --    | 0.04          | 10                    |         |
|  | --           | 0.15            | 15              | 20   | 20        | 600     | 600     | --    | 0.04          | 20                    |         |
|  | --           | 0.20            | 20              | 100  | 100       | 3000    | 3000    | --    | 0.08          | 100                   |         |
| Output Low<br>(Sink) Current<br>$I_{OL}$ Min.      | 0.4          | 0.5             | 5               | 0.64   | 0.61      | 0.42    | 0.36    | 0.51  | 1             | --                    | $mA$    |
|  | 0.5          | 0.10            | 10              | 1.6  | 1.5       | 1.1     | 0.9     | 1.3   | 2.6           | --                    |         |
|  | 1.5          | 0.15            | 15              | 4.2  | 4         | 2.8     | 2.4     | 3.4   | 6.8           | --                    |         |
| Output High<br>(Source) Current,<br>$I_{OH}$ Min.  | 4.6          | 0.5             | 5               | -0.64  | -0.61     | -0.42   | -0.36   | -0.51 | -1            | --                    | $mA$    |
|  | 2.5          | 0.5             | 5               | -2   | -1.8      | -1.3    | -1.15   | -1.6  | -3.2          | --                    |         |
|  | 9.5          | 0.10            | 10              | -1.6   | -1.5      | -1.1    | -0.9    | -1.3  | -2.6          | --                    |         |
|  | 13.5         | 0.15            | 15              | -4.2   | -4        | -2.8    | -2.4    | -3.4  | -6.8          | --                    |         |
| Output Voltage:<br>Low-Level,<br>$V_{OL}$ Max.     | --           | 0.5             | 5               | 0.05   |           |         |         | --    | 0             | 0.05                  | $V$     |
|  | --           | 0.10            | 10              | 0.05   |           |         |         | --    | 0             | 0.05                  |         |
|  | --           | 0.15            | 15              | 0.05   |           |         |         | --    | 0             | 0.05                  |         |
| Output<br>Voltage:<br>High-Level,<br>$V_{OH}$ Min. | --           | 0.5             | 5               | 4.95   |           |         |         | 4.95  | 5             | --                    | $V$     |
|  | --           | 0.10            | 10              | 9.95   |           |         |         | 9.95  | 10            | --                    |         |
|  | --           | 0.15            | 15              | 14.95  |           |         |         | 14.95 | 15            | --                    |         |
| Input Low<br>Voltage<br>$V_{IL}$ Max.              | 0.5,4.5      | --              | 5               | 1.5  |           |         |         | --    | --            | 1.5                   | $V$     |
|  | 1.9          | --              | 10              | 3  |           |         |         | --    | --            | 3                     |         |
|  | 1.5,13.5     | --              | 15              | 4  |           |         |         | --    | --            | 4                     |         |
| Input High<br>Voltage,<br>$V_{IH}$ Min.            | 0.5,4.5      | --              | 5               | 3.5  |           |         |         | 3.5   | --            | --                    | $V$     |
|  | 1.9          | --              | 10              | 7  |           |         |         | 7     | --            | --                    |         |
|  | 1.5,13.5     | --              | 15              | 11   |           |         |         | 11    | --            | --                    |         |
| Input Current<br>$I_{IN}$ Max.                     | --           | 0.18            | 18              | $\pm 0.1$  | $\pm 0.1$ | $\pm 1$ | $\pm 1$ | --    | $\pm 10^{-5}$ | $\pm 0.1$             | $\mu A$ |

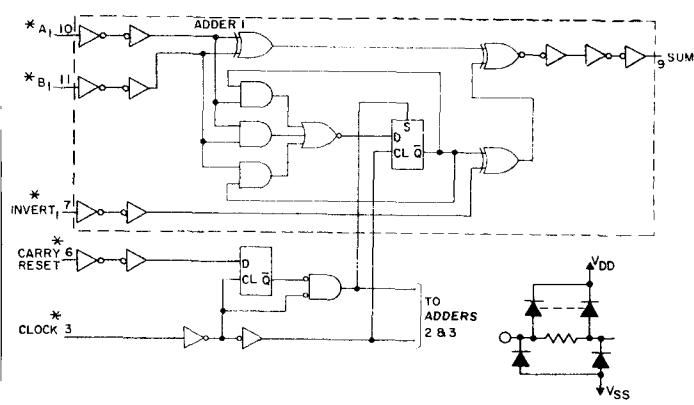


Fig.1 — CD4032B logic diagram of one of three serial adders.

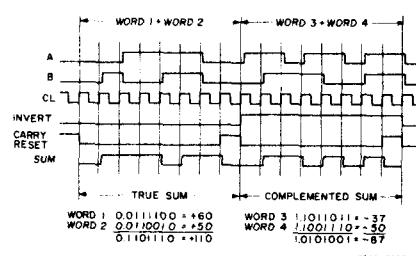


Fig.2 — CD4032B timing diagram.

## CD4032B, CD4038B Types

DYNAMIC ELECTRICAL CHARACTERISTICS at  $T_A = 25^\circ C$ , Input  $t_r, t_f = 20 \text{ ns}$ ,  
 $C_L = 50 \text{ pF}, R_L = 200 \text{ k}\Omega$

| CHARACTERISTIC   | TEST CONDITIONS<br>$V_{DD}(\text{V})$ | LIMITS |      |      | UNITS         |
|--|---------------------------------------|--------|------|------|---------------|
|  |                                       | Min.   | Typ. | Max. |               |
| Propagation Delay Time: $t_{PHL}, t_{PLH}$<br>A, B, Carry Reset, or Invert Inputs to Sum Outputs | 5                                     | —      | 260  | 520  | ns            |
|  | 10                                    | —      | 120  | 240  |               |
|  | 15                                    | —      | 90   | 180  |               |
| Clock Input to Sum Outputs   | 5                                     | —      | 325  | 650  | ns            |
|  | 10                                    | —      | 175  | 350  |               |
|  | 15                                    | —      | 150  | 300  |               |
| Transition Time: $t_{THL}, t_{TLH}$  | 5                                     | —      | 100  | 200  | ns            |
|  | 10                                    | —      | 50   | 100  |               |
|  | 15                                    | —      | 40   | 80   |               |
| Minimum Data Input Setup Time, $t_{SU}$<br>Clock to A or B Inputs                                | 5                                     | —      | 125  | 200  | ns            |
|  | 10                                    | —      | 50   | 80   |               |
|  | 15                                    | —      | 40   | 60   |               |
| Maximum Clock Input Frequency, $f_{CL}$  | 5                                     | 2.5    | 4.5  | —    | MHz           |
|  | 10                                    | 5      | 10   | —    |               |
|  | 15                                    | 7.5    | 15   | —    |               |
| Clock Input Rise or Fall Time, $t_{rCL}, t_{fCL}^*$  | 5                                     | —      | —    | 500  | $\mu\text{s}$ |
|  | 10                                    | —      | —    | 500  |               |
|  | 15                                    | —      | —    | 500  |               |
| Input Capacitance, $C_{IN}$  | (Any Input)                           | —      | 5    | 7.5  | pF            |

\* If more than one unit is cascaded  $t_{rCL}$  should be made less than or equal to the sum of the transition time and the fixed propagation delay of the output of the driving stage for the estimated capacitive load.

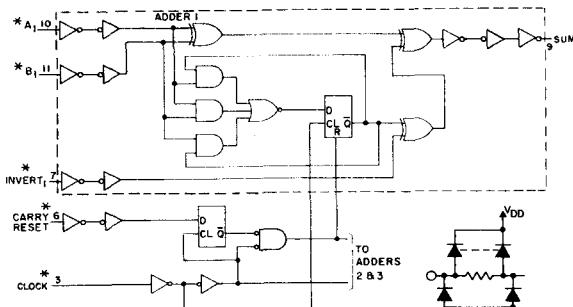


Fig. 3 – CD4038B logic diagram of one of three serial adders.

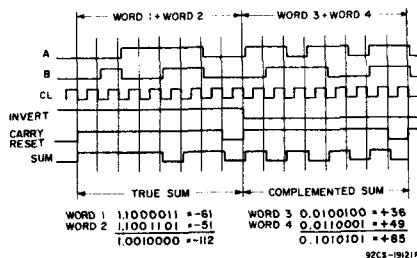


Fig. 4 – CD4038B timing diagram.

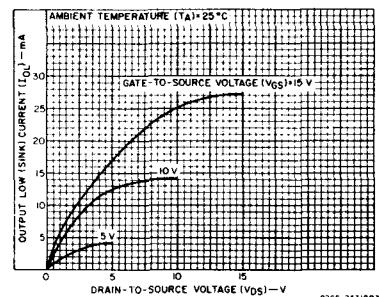


Fig. 5 – Typical output low (sink) current characteristics.

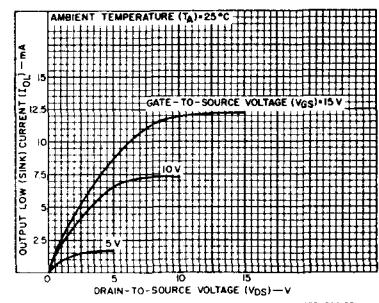


Fig. 6 – Minimum output low (sink) current characteristics.

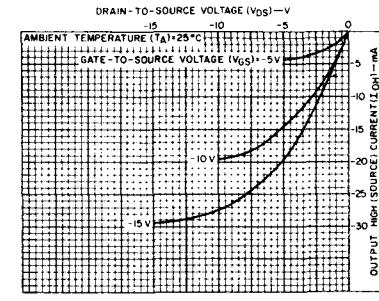


Fig. 7 – Typical output high (source) current characteristics.

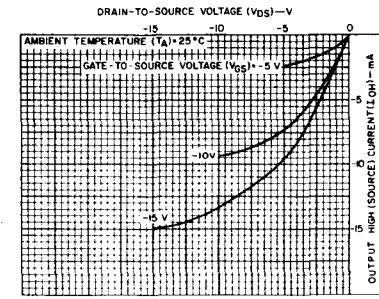


Fig. 8 – Minimum output high (source) current characteristics.

## CD4032B, CD4038B Types

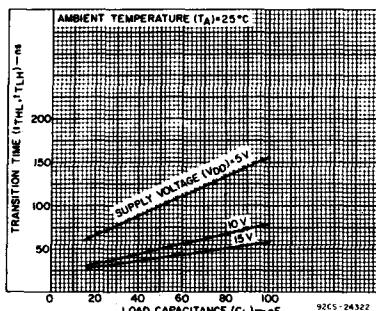


Fig. 9 – Typical transition time as a function of load capacitance.

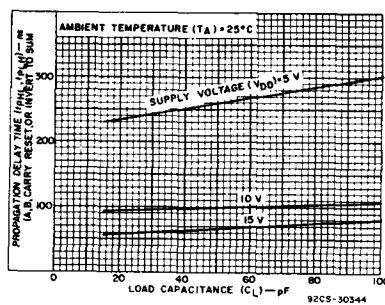


Fig. 10 – Typical propagation delay times as a function of load capacitance (A, B, carry reset or invert to SUM).

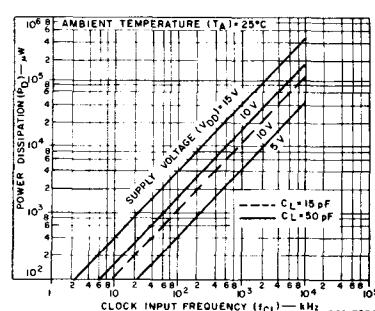


Fig. 11 – Typical dynamic power dissipation as a function of clock input frequency.

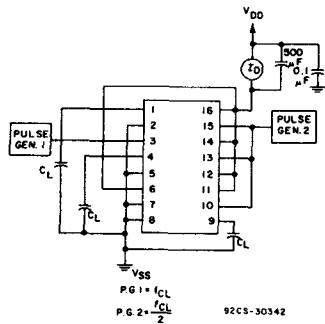


Fig. 12 – Dynamic power dissipation test circuit.

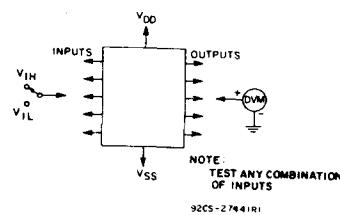


Fig. 13 – Input voltage test circuit.

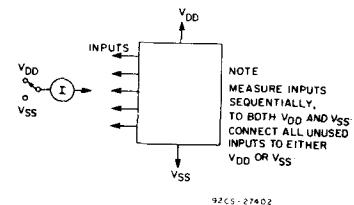


Fig. 14 – Input current test circuit.

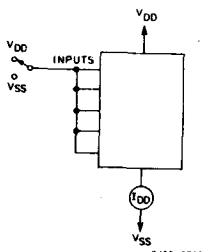
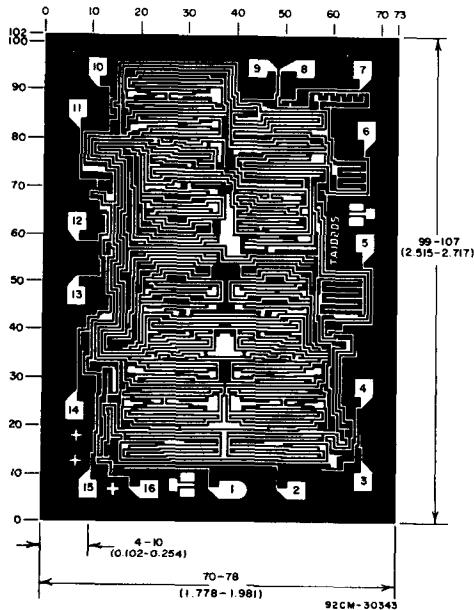


Fig. 15 – Quiescent-device current test circuit.

Dimensions in parentheses are in millimeters and are derived from the basic inch dimensions as indicated. Grid graduations are in mils ( $10^{-3}$  inch).

The photographs and dimensions of each CMOS chip represent a chip when it is part of the wafer. When the wafer is separated into individual chips, the angle of cleavage may vary with respect to the chip face for different chips. The actual dimensions of the isolated chip, therefore, may differ slightly from the nominal dimensions shown. The user should consider a tolerance of -3 mils to +10 mils applicable to the nominal dimensions shown.



Dimensions and pad layout for CD4032BH; dimensions and pad layout for CD4038BH are identical.